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APPLICATION NO.	D. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/697,015 10/31/2003		Yoshinori Shizuno	OHG 140	8235	
23995	7590	03/10/2006		EXAMINER	
RABIN & Berdo, PC 1101 14TH STREET, NW			PAREKH, NITIN		
SUITE 500 WASHINGTON, DC 20005				ART UNIT	PAPER NUMBER
				2811	<u> </u>

DATE MAILED: 03/10/2006

Please find below and/or attached an Office communication concerning this application or proceeding.



Supp

Application No.	Applicant(s)	
10/697,015	SHIZUNO, YOSHINORI	
Examiner	Art Unit	
Nitin Parekh	2811	

10/6	97,015	SHIZUNU, TUSHINUKI	
Notice of Allowability Exam	miner	Art Unit	
Nitin	Parekh	2811	
The MAILING DATE of this communication appears of All claims being allowable, PROSECUTION ON THE MERITS IS (OR R herewith (or previously mailed), a Notice of Allowance (PTOL-85) or oth NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS of the Office or upon petition by the applicant. See 37 CFR 1.313 and Market See 20 CFR 1.313 and Market See 20 CFR 1.313 and Market See 20 CFR 1.313 and Market See 31 CFR 1.313 a	REMAINS) CLOSED in this a ner appropriate communication. This application is subject	pplication. If not included on will be mailed in due course. THIS	
1. X This communication is responsive to <u>06-24-05</u> .			
2. The allowed claim(s) is/are <u>1-4, 6, 7, 18-20 and 22-24</u> .			
3. \boxtimes The drawings filed on <u>06 June 2005</u> are accepted by the Examin	er.		
 4. Acknowledgment is made of a claim for foreign priority under 3st a) All b) Some* c) None of the: 1. Certified copies of the priority documents have been 2. Certified copies of the priority documents have been 3. Copies of the certified copies of the priority document International Bureau (PCT Rule 17.2(a)). * Certified copies not received: Applicant has THREE MONTHS FROM THE "MAILING DATE" of this noted below. Failure to timely comply will result in ABANDONMENT of THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 5. A SUBSTITUTE OATH OR DECLARATION must be submitted. INFORMAL PATENT APPLICATION (PTO-152) which gives real (a) including changes required by the Notice of Draftsperson's Failure to or 2) To Paper No./Mail Date (b) including changes required by the attached Examiner's Ame Paper No./Mail Date Identifying indicia such as the application number (see 37 CFR 1.84(c)) each sheet. Replacement sheet(s) should be labeled as such in the hear of the paper No./Mail Date DEPOSIT OF and/or INFORMATION about the deposit of attached Examiner's comment regarding REQUIREMENT FOR attached Examiner's comment regar	received. received in Application No. Ints have been received in this communication to file a replication. Note the attached EXAMINE son(s) why the oath or declar submitted. Patent Drawing Review (PTC endment / Comment or in the should be written on the drawader according to 37 CFR 1.12:	s national stage application from the y complying with the requirements R'S AMENDMENT or NOTICE OF ration is deficient. D-948) attached Office action of wings in the front (not the back) of 1(d). must be submitted. Note the	
Attachment(s) 1. Notice of References Cited (PTO-892) 2. Notice of Draftperson's Patent Drawing Review (PTO-948) 3. Information Disclosure Statements (PTO-1449 or PTO/SB/08), Paper No./Mail Date 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material	6. ☐ Interview Summa Paper No./Mail D 7. ☑ Examiner's Amen	ate .	

U.S. Patent and Trademark Office PTOL-37 (Rev. 1-04)

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DETAILED ACTION

Allowable Subject Matter

1. Claims 1-4, 6, 7, 18-20 and 22-24 are allowed.

Supplemental Examiner's Amendment

- 2. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
- A. Cancel claims 9 and 21.
- B. Claim 19, line 15: Delete "and"
- C. At the end of claim 19, line 17: Insert --- "and a plurality of electrode posts formed between said wiring patterns and said external terminals, wherein said sealing portion is formed such that a top surface of said electrode posts is exposed." ---.
- D. Claim 22, line 1: Delete "claim 21" and insert --- "claim 19" ---.

Authorization for this examiner's amendment was given in a telephone interview with Nick Bromer on 08-18-05.

Reasons for Allowance

2. The following is an examiner's statement of reasons for allowance:

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The references of record do not teach either singularly or in combination at least the limitations "a base frame including a first surface, and a second surface which opposes said first surface, and including an opening portion formed through the base frame", "said semiconductor chip being disposed within said opening portion such that the level of said first main surface is substantially equal to the level of said first surface", "portions of said wiring patterns on a boundary and vicinity thereof between a region on the upper side of said semiconductor chip and the base frame being wider or thicker than other portions of said wiring patterns" and "a plurality of external terminals provided included over said wiring patterns in a region including the upper side of said base frame" in a resin sealed device having a semiconductor chip being disposed in the opening in a base frame, or "a silicon wafer constituting a base frame including a first surface, and a second surface which opposes said first surface, and including an opening portion formed through the base frame", "said semiconductor chip being disposed within said opening portion such that the level of said first main surface is substantially equal to the level of said first surface", and "a plurality of electrode posts formed between said wiring patterns and said external terminals, wherein said sealing portion is formed such that a top surface of said electrode posts is exposed" in a resin sealed device having a semiconductor chip being disposed in the opening in a silicon wafer and a plurality of wiring patterns being electrically connected to the respective electrode pads and external terminals.

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Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Nitin Parekh whose telephone number is 571-272-1663. The examiner can normally be reached on 09:00AM-05:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lee can be reached on 571-272-1732. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAN or Public PAG. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAG system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). Any inquiry of a general nature or relating to the

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status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

NP

12-28-05

NITIN PAREKH

Ntin Parelle

PRIMARY EXAMINER

TECHNOLOGY CENTER 2800